

GS-1220-DMS Display Measurement System



GS-1220 Display Measurement Systems can capture spectral measurements of displays in milliseconds with ultra-low uncertainty. Any application that demands high sensitivity in the blue-light region, such as LED backlit displays, will benefit from the system's back-thinned CCD technology. Models are available in three configurations, covering spectral ranges from 250-900 nm, 360-900 nm or 360-1100 nm. Interchangeable system components are available for easy customization and integration. All systems come with our powerful Light Touch™ spectral data acquisition and analysis software package, available in both engineering/R&D and QC/production line versions.

Exceptional Sensitivity and Speed for Display Characterization

- Superior wavelength and color accuracy via low thermal expansion coefficient materials
- Luminance measurements down to 0.0015 cd/m²
- Low polarization error
- Resolution better than 0.3 nm/pixel
- Original system calibration in our NVLAP accredited laboratory using NIST-traceable standards
- Can be field calibrated by the end user if a known standard is present

Original system calibration is performed in Gamma Scientific's NVLAP accredited laboratory (NVLAP Lab Code 200823-0) using NIST-traceable standards.

GS-1220-DMS Display Measurement System



Detector & Wavelength Specifications		GS-1220-DMS-0		GS-1220-DMS-1		GS-1220-DMS-2	
Nominal Spectral Range		250 to 900 nm (UV-VIS)		360 to 900 nm (VIS)		360 to 1100 nm (VIS-NIR)	
Data Point Interval 0.32		0.32 nm		0.32 nm		0.35nm	
Spectral Bandwidth		Integrated user-selectable Half-Power-Bandwidth. Highlighted values are factory default settings					
		10.0 nm		10.0 nm		10.0 nm	
		5.0 nm		5.0 nm		5.0 nm	
		2.5 nm		2.5 nm		2.5 nm	
		1.4 nm		1.4 nm		1.4 nm	
		1.0 nm		1.0 nm		1.0 nm	
Wavelength Repeatability (0.02 nm		0.02 nm		0.02 nm	
Wavelength Accuracy ± 0.		± 0.1 nm		± 0.1 nm		± 0.1 nm	
			Com	mon Specificatio	ns		
Stray Light		< 1.0 x 10)-4				
Polarization Error ⁽¹⁾		< 1%					
Measuring Angle 5		5°, 2°, 1°, 0.5°, 0.33°, or 0.1° (user selectable)					
Minimum Measuring Distance 69		69 mm with macro lens. Single calibration valid from 100 mm to ∞					
Integration Time		2 μsec to 2.67 sec					
Control Software		USB 2.0 interface with Light Touch™ software for Windows® Analysis in CIE1931 XYZ and xy; CIE1976 UCS u'v'; CIE1976 L*u*v* and L*a*b*; CIE 1964 XYZ					
Operating Conditions		0 to 35° C at relative humidity , 95% (non-condensing) 100 – 240 VAC at 50/60 Hz					
Dimensions		133 mm (5.3 in) H x 305 mm (12 in) W x 260 mm (10.2 in) L 9 kg (20 lbs.)					
			Sensit	ivity and Accura	cy ⁽²⁾		
Aperture Size	5°		2°	1°	0.5°	0.33°	0.1°
Sensitivity (cd/m²)	0.0015 to 1,125		0.002 to 1,650	0.009 to 6,750	0.03 to 28,100	0.16 to 120,000	0.9 to 675,000
Chromaticity Accuracy	x,y: ±0.0020 (0.0015-0.05 cd/m²)		x,y: ±0.0025 (0.002-0.07 cd/m2)	x,y: ±0.0025 (0.009-0.3 cd/m²)	x,y: ±0.0025 (0.03-1.1 cd/m²)	x,y: ±0.0025 (0.16-5.1 cd/m²)	x,y: ±0.0025 (0.9-29 cd/m²)
	x,y: ±0.0015 (0.05-1,125 cd/m²)		x,y: ±0.0015 (0.07-1,650 cd/m²)	x,y: ±0.0015 (0.03-6,750 cd/m²)	x,y: ±0.0015 (1.1-28,100 cd/m²)	x,y: ±0.0015 (5.1-120,000 cd/m²)	x,y: ±0.0015 (29-675.000 cd/m ²)
	,	, ,		0 mm Compact Macro	, , ,	, , ,	
Spot Size @ 69mm	ø 9.83 mm		ø 3.93 mm	ø 1.97 mm	ø 0.98 mm	ø 0.65 mm	ø 0.20 mm
Spot Size @ 100mm	ø 10.49 mm		ø 4.20 mm	ø 2.10 mm	ø 1.05 mm	ø 0.69 mm	ø 0.21 mm
Spot Size @ 279mm	ø 28.26 mm		ø 11.30 mm	ø 5.65 mm	ø 2.83 mm	ø 1.86 mm	ø 0.57 mm
		Canon	50 mm Compact Mac	ro 1:2.5 with Life-size	Converter EF; MAG =	1.46	
Spot Size @ 69mm	ø 4.83 mm		ø 1.93 mm	ø 0.97 mm	ø 0.48 mm	ø 0.32 mm	ø 0.10 mm
Spot Size @ 100mm	ø 6.86 mm		ø 2.74 mm	ø 1.37 mm	ø 0.69 mm	ø 0.45 mm	ø 0.14 mm
Spot Size @ 279mm	e @ 279mm ø 19.37 mm		ø 7.75 mm	ø 3.87 mm	ø 1.94 mm	ø 1.28 mm	ø 0.39 mm
			Tamı	on 180 mm Macro 1:	3.5		
Spot Size @ 279mm	ø 10.49 mm		ø 4.20 mm	ø 2.10 mm	ø 1.05 mm	ø 0.69 mm	ø 0.21 mm

⁽¹⁾ Measuring linearly polarized light through a Glan-Thompson prism



⁽²⁾ Sensitivity specifications assume a 10:1 signal-to-noise ratio based on the percent coefficient of variance measuring the luminance of a CIE illuminant A source. Specifications are subject to change without notice.